

**Notice of References Cited**

Application/Control No.

10/533,368

Applicant(s)/Patent Under  
Reexamination  
LEN ET AL.

Examiner

STEPHEN YANCHUK

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0186096	10-2003	Keskula et al.	429/25
*	B	US-2003/0031902	02-2003	Balasubramanian et al.	429/22
*	C	US-2003/0186096	10-2003	Keskula et al.	429/25
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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